## PRSA-L100-F500-Si-PCB Silicon piezo-resistive sensing cantilevers



## **General description**

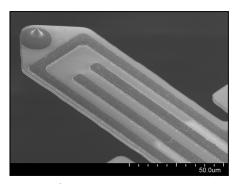
Piezo-Resistive Sensing Active (PRSA) probes are silicon cantilevers with an integrated piezo-resistor and a heater for self-sensing and self-actuating scanning probe microscopy applications. The piezo-resistors are integrated into a matched Wheatstone bridge to raise the sensitivity and compensate environmental thermal drift. By using the self-sensing readout no laser adjustment is necessary in comparison to conventional optical readout AFM systems. This saves time during a cantilever change. The free space above the cantilever enables new applications and combination of AFM with various instruments. The cantilever chip is bonded to a small printed circuit board (PCB) with a small connector for a quick cantilever change. The counter part PCB for the cantilever PCB can be connected to a low-noise pre-amplifier with a flat flex cable.

| Specifications                |  |
|-------------------------------|--|
| Model                         | PRSA-L100-F500-Si-PCB  |
| Tip radius (apex)             | <15 nm   |
| Tip height                    | 46 μm  |
| Tip material                  | silicon  |
| Resonant frequency            | 200800 kHz   |
| Spring constant               | 8530 N/m   |
| Recomm. AFM mode              | tapping, non-contact   |
| sensitivity*                  | 13 μV/nm   |
| force sensitivity*            | 2.7530 nN/μV   |
| Length, width                 | 110 ±5 μm, 48 ±2 μm  |
| Material                      | silicon cantilever, boron doped 1k Ohm piezo resistors, aluminium tracks                         |
| Deflection sensing            | on chip piezo-resistive bridge   |
| Actuator                      | external shaker or on chip heater (12 +/-3 Ohm)  |
| Electrical connections        | bonded to small PCB with connector (counter part PCB available) or optional bonding pads on chip |
| Chip dimensions (h, w, l)     | 0.3 / 1.0 / 2.7 mm   |
| * not amplified, 2.048 V brid | dge supply   |

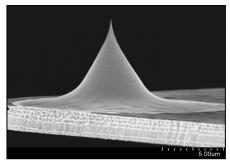
## **Applications:**

- Integration on a standard AFM scanner and high-speed AFM
- Force or deflection measurements within TEM, SEM, XPS, etc.

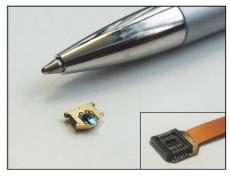
## What about your application? Contact us!



Tip side of a PRSA-L100 cantilever with Al tracks for reading out the deflection signal



Side view of a PRSA-L100 cantilever



Cantilever is bonded to a 6 x 4.5 mm PCB (height with connector 1.6 mm, complete height connected to CP-PCB: 1.8 mm); right: counter part PCB



Hardware for amplified readout: Low-noise pre-amplifier (45x35 mm)